

**a** 302 992 2953

09/01	12.11	☐ :02/07	NO - 570
09/01	12.11	L02/01	NO:57

·	Application No.	Applicant(s)
Interview Summary	09/494,107	Lee at al
mterview Sammary	Examiner First Las	Group Art Unit 1234
All participants (applicant, applicant's representative, PTC	) personnel):	
(1) Jeffrey Mullis	(3) <u>I-nwa Lee</u>	
(2) Kevin Dobson	(4) Barry Morr	is
Date of Interview Oct 2, 2001		
Type: a: Telephonic b) \( \text{Video Conference} \) c) X Personal (copy is given to 1) \( \begin{align*} \text{applicant} \\ \end{align*}		
Exhibit shown or demonstration conducted: d) 🔀 Yes Exhibit shown indicating factorws effected by speed of li	e) No. If yes, b amination process	prief description:
		-
Claim(s) discussed: all		
Identification of prior art discussed: all relied upon		
an remed upon	-	
Applicants attorneys argued that there was no reasonable using rapid film fabrication processes as opposed to othe examiner that it was not clear if the processes of Lee'ws Applicants argued that there were unexpected results with specifically rapid film fabrication processes were used.	r processes of the pri s examples anticipated	or art but it was the position of the distance of the distance claims embracing blown films.
(A fuller description, if necessary, and a copy of the ame	indments which the e	xaminer agreed would render the claims
allowable, if available, must be attached. Also, where neavailable, a summary thereof must be attached.)	o copy of the amendin	nents that would render the claims allowable
i) It is not necessary for applicant to provide a set		
Unless the paragraph above has been checked, THE FOR INCLUDE THE SUBSTANCE OF THE INTERVIEW. (See A already been filed, APPLICANT IS GIVEN ONE MONTH F SUBSTANCE OF THE INTERVIEW. See Summary of Rec	APEP section 713.04). ROM THIS INTERVIEV	W DATE TO FILE A STATEMENT OF THE
	Jeffrey Muliis	5 nor
	Primary Exami Art Unit 171	
Examinar Note: You must sign this form unless it is an Attachment to a signed Office action.		
9. Patent and Tradamerk Office (O-413 (Rev. 03-98) Inter	view Summary	Part of Paper No. 12